

International **IR** Rectifier

- Logic Level Gate Drive
- Ultra Low On-Resistance
- Surface Mount (IRLR3410)
- Straight Lead (IRLU3410)
- Advanced Process Technology
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The D-PAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 watts are possible in typical surface mount applications.

Absolute Maximum Ratings

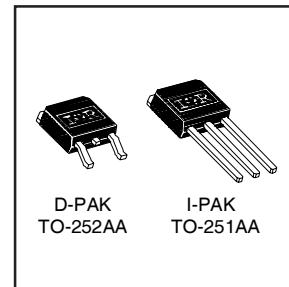
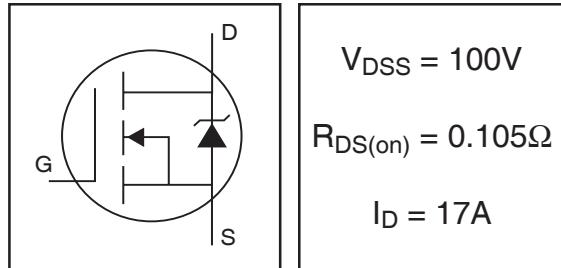
	Parameter	Max.	Units
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	17	
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	12	A
I_{DM}	Pulsed Drain Current ①②	60	
$P_D @ T_C = 25^\circ\text{C}$	Power Dissipation	79	W
	Linear Derating Factor	0.53	W/ $^\circ\text{C}$
V_{GS}	Gate-to-Source Voltage	± 16	V
E_{AS}	Single Pulse Avalanche Energy ②③	150	mJ
I_{AR}	Avalanche Current ①③	9.0	A
E_{AR}	Repetitive Avalanche Energy ①③	7.9	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T_J	Operating Junction and	-55 to + 175	
T_{STG}	Storage Temperature Range		$^\circ\text{C}$
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

	Parameter	Typ.	Max.	Units
R_{0JC}	Junction-to-Case	—	1.9	
R_{0JA}	Junction-to-Ambient (PCB mount) **	—	50	$^\circ\text{C}/\text{W}$
R_{0JA}	Junction-to-Ambient	—	110	

IRLR/U3410PbF

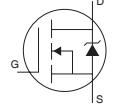
HEXFET® Power MOSFET



Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0V, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.122	—	V°C	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.105	W	$V_{GS} = 10V, I_D = 10\text{A}$ ④
		—	—	0.125		$V_{GS} = 5.0V, I_D = 10\text{A}$ ④
		—	—	0.155		$V_{GS} = 4.0V, I_D = 9.0\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	1.0	—	2.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
g_f	Forward Transconductance	7.7	—	—	S	$V_{DS} = 25V, I_D = 9.0\text{A}$ ⑤
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS} = 100V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 80V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 16V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -16V$
Q_g	Total Gate Charge	—	—	34	nC	$I_D = 9.0\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	4.8		$V_{DS} = 80V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	20		$V_{GS} = 5.0V$, See Fig. 6 and 13 ④⑤
$t_{d(on)}$	Turn-On Delay Time	—	7.2	—	ns	$V_{DD} = 50V$
t_r	Rise Time	—	53	—		$I_D = 9.0\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	30	—		$R_G = 6.0\Omega, V_{GS} = 5.0V$
t_f	Fall Time	—	26	—		$R_D = 5.5\Omega$, See Fig. 10 ④⑤
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact ⑥
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	800	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	160	—		$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	—	90	—		$f = 1.0\text{MHz}$, See Fig. 5 ⑤

Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)	—	—	17	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode) ①⑤	—	—	60		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 9.0\text{A}, V_{GS} = 0V$ ④
t_{rr}	Reverse Recovery Time	—	140	210	ns	$T_J = 25^\circ\text{C}, I_F = 9.0\text{A}$
Q_{rr}	Reverse Recovery Charge	—	740	1100	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④⑤
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② $V_{DD} = 25V$, starting $T_J = 25^\circ\text{C}$, $L = 3.1\text{mH}$
 $R_G = 25\Omega, I_{AS} = 9.0\text{A}$. (See Figure 12)
- ③ $I_{SD} \leq 9.0\text{A}$, $dI/dt \leq 540\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$
- ④ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$
- ⑤ Uses IRL530N data and test conditions
- ⑥ This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact

** When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994

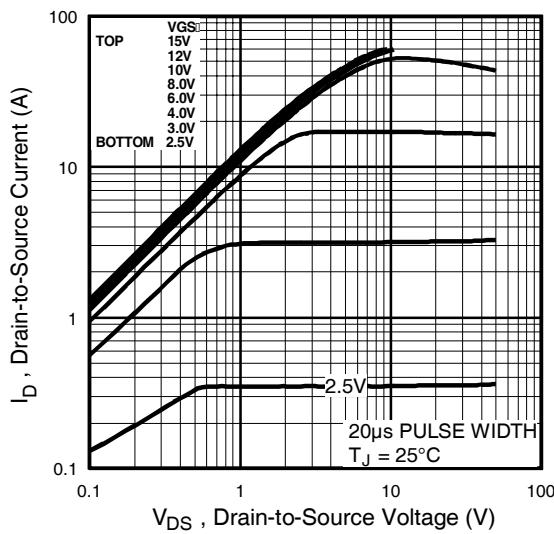


Fig 1. Typical Output Characteristics

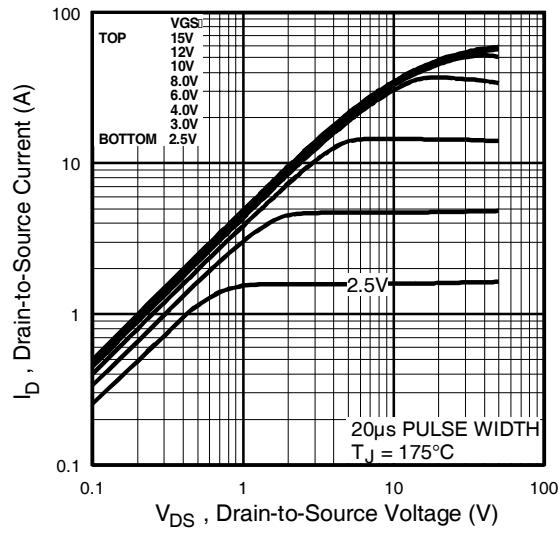


Fig 2. Typical Output Characteristics

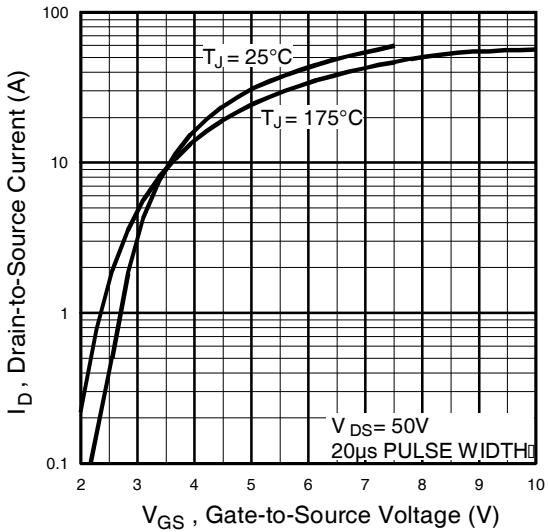


Fig 3. Typical Transfer Characteristics

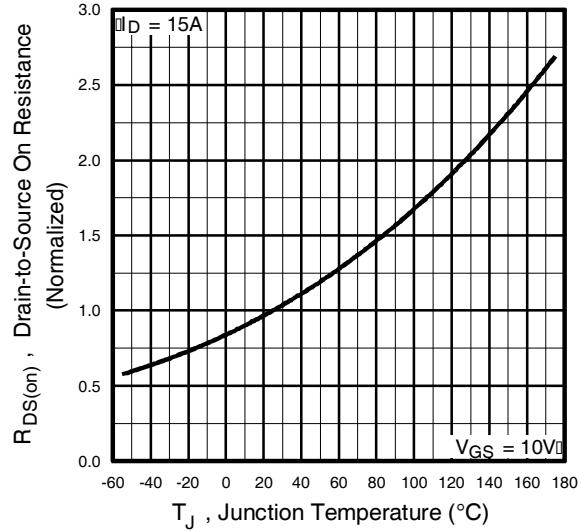


Fig 4. Normalized On-Resistance Vs. Temperature

IRLR/U3410PbF

International
IR Rectifier

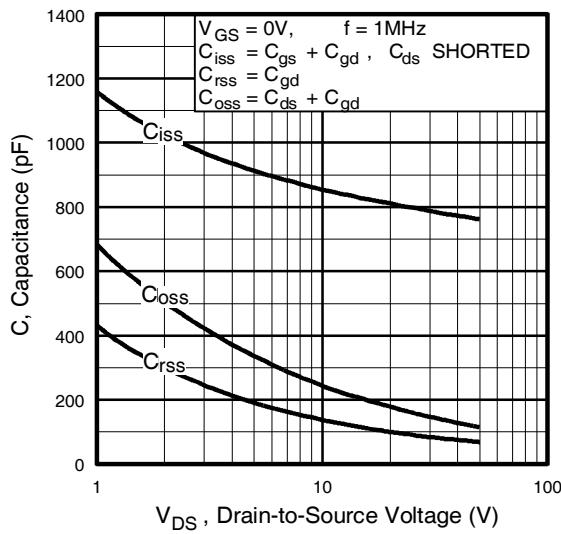


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

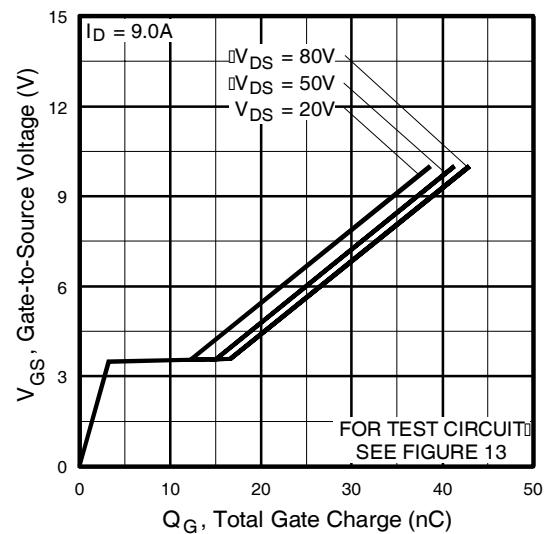


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

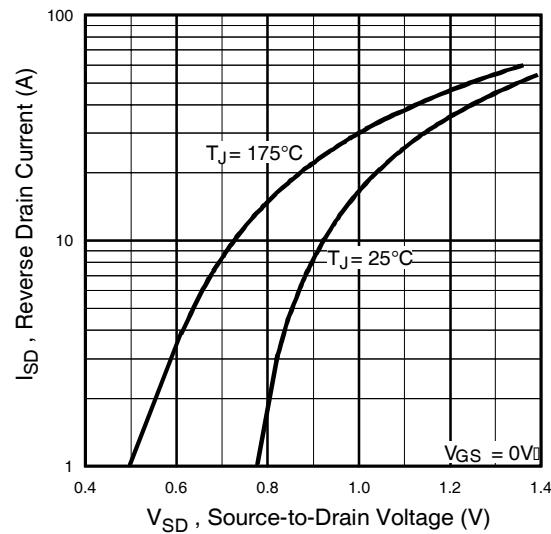


Fig 7. Typical Source-Drain Diode
Forward Voltage

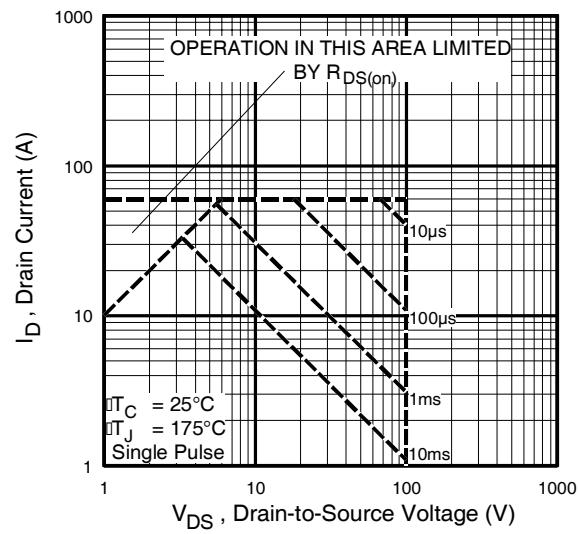


Fig 8. Maximum Safe Operating Area

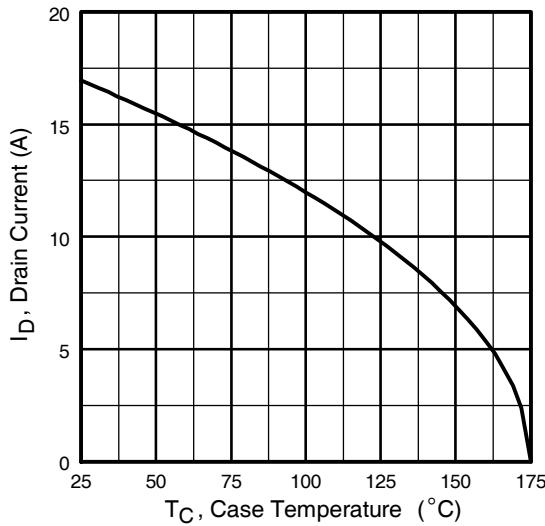


Fig 9. Maximum Drain Current Vs.
Case Temperature

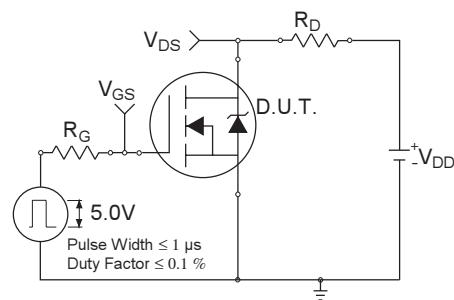


Fig 10a. Switching Time Test Circuit

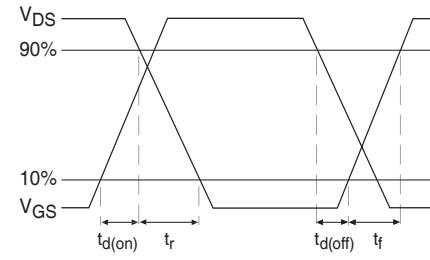


Fig 10b. Switching Time Waveforms

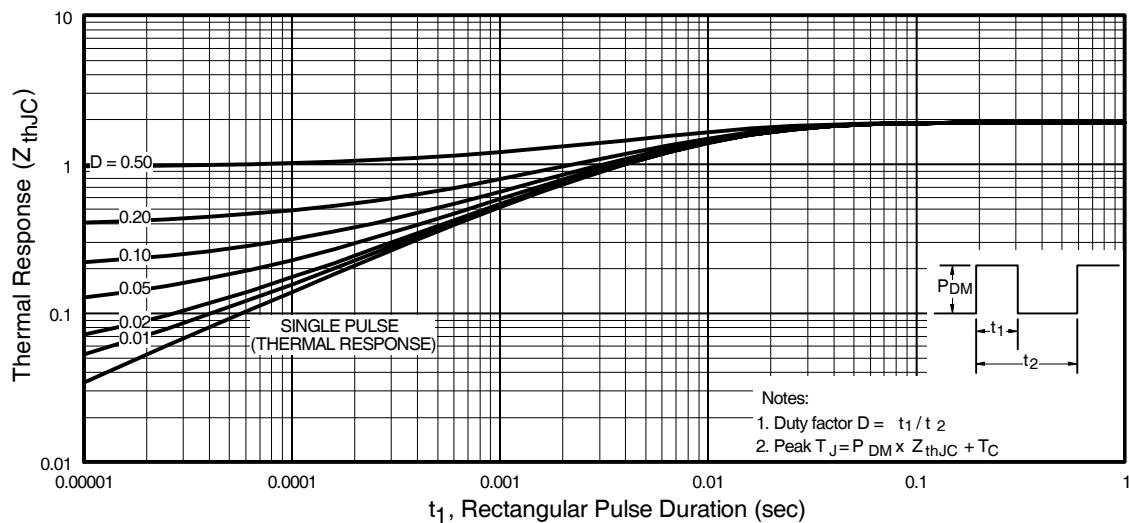


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

IRLR/U3410PbF

International
IR Rectifier

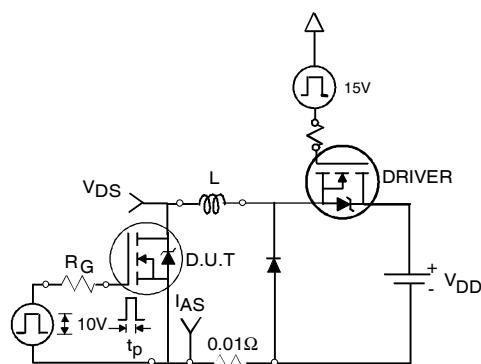


Fig 12a. Unclamped Inductive Test Circuit

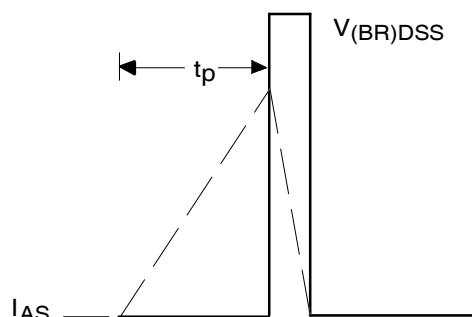


Fig 12b. Unclamped Inductive Waveforms

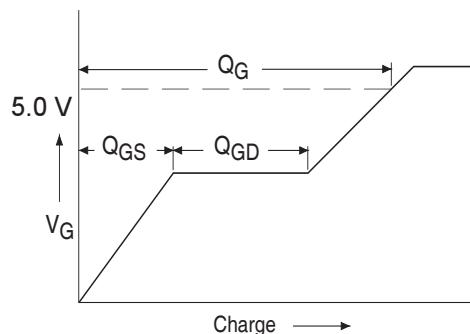


Fig 13a. Basic Gate Charge Waveform

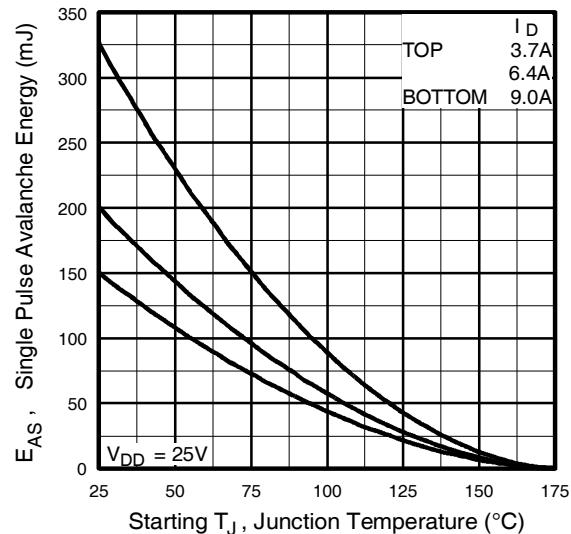


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

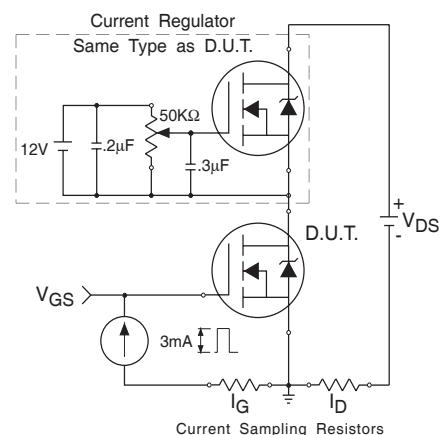
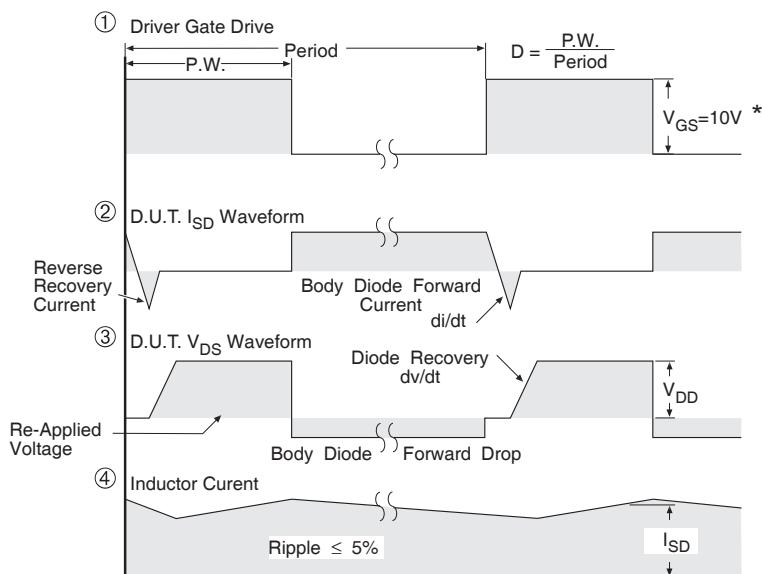
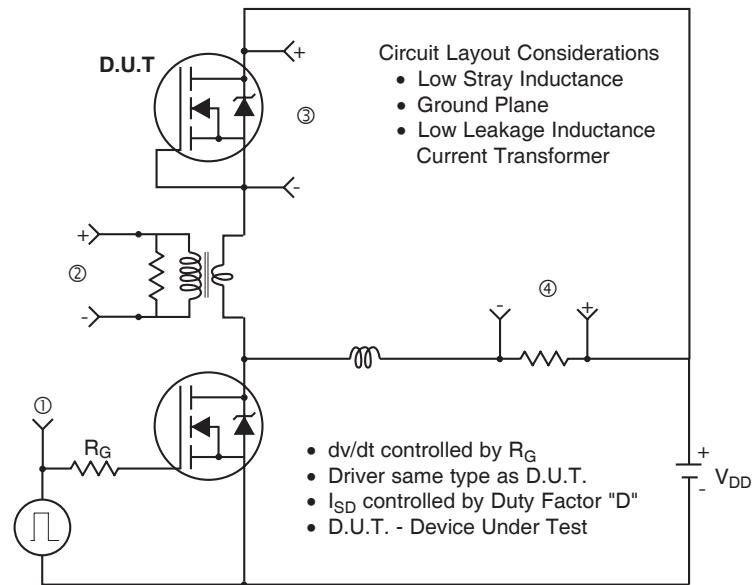


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



* $V_{GS} = 5V$ for Logic Level Devices

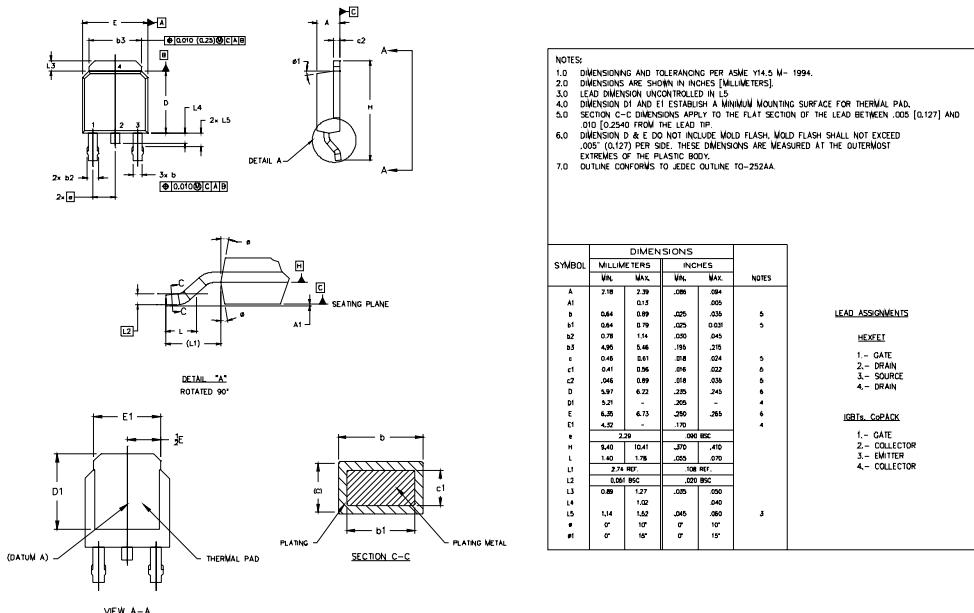
Fig 14. For N-Channel HEXFETS

IRLR/U3410PbF

International
IR Rectifier

D-Pak (TO-252AA) Package Outline

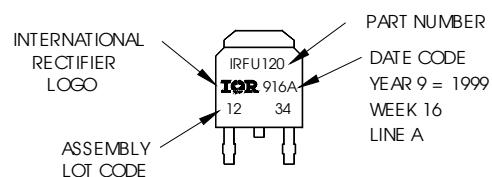
Dimensions are shown in millimeters (inches)



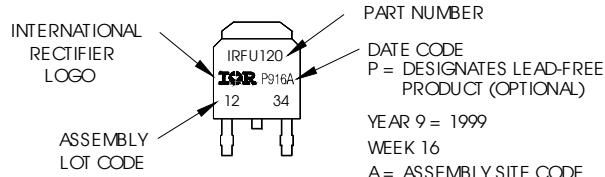
D-Pak (TO-252AA) Part Marking Information

EXAMPLE: THIS IS AN IRFR120
WITH ASSEMBLY
LOT CODE 1234
ASSEMBLED ON WW 16, 1999
IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line position
indicates "Lead-Free"

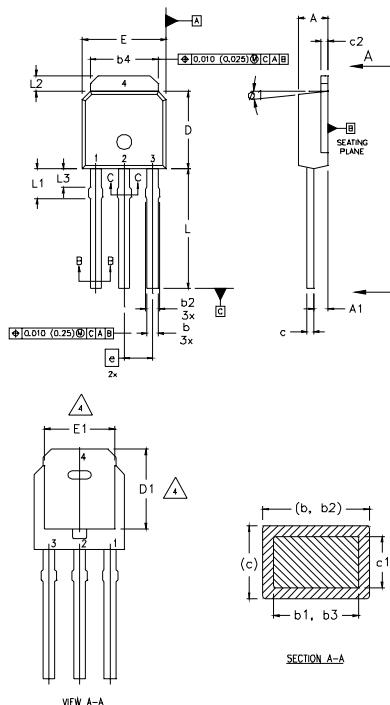


OR



I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION b4, L2, E1 & D1.
- 5 LEAD DIMENSION UNCONTROLLED TO L3.
- 6 DIMENSION b1, b3 APPLY TO BASE METAL ONLY.
- 7 OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.
- 8 CONTROLLING DIMENSION : INCHES.

LEAD ASSIGNMENTS

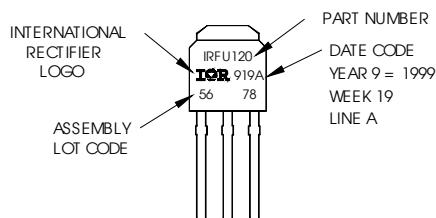
SYMBOL	DIMENSIONS		NOTES
	MILLIMETERS	INCHES	
	MIN.	MAX.	
A	2.18	2.39	0.086 .094
A1	0.89	1.14	0.035 .045
b	0.64	0.89	0.025 .035
b1	0.64	0.79	0.025 .031
b2	0.76	1.14	0.030 .045
b3	0.76	1.04	0.030 .041
b4	5.00	5.46	0.195 .215
c	0.46	0.61	0.018 .024
c1	0.41	0.56	0.016 .022
c2	.046	0.86	0.018 .035
D	5.97	6.22	0.235 .245
D1	5.21	-	0.205 -
E	6.36	6.73	0.250 .265
E1	4.32	-	0.170 -
e	2.29	-	0.090 BSC
L	8.89	9.60	0.350 .380
L1	1.91	2.29	0.075 .090
L2	0.89	1.27	0.035 .050
L3	1.14	1.52	0.045 .060
ø1	ø7	ø15	ø7 ø15

HEXFET
 1.- GATE
 2.- DRAIN
 3.- SOURCE
 4.- DRAIN

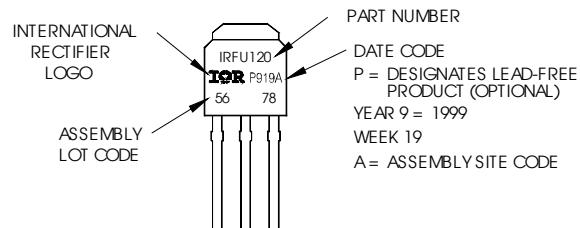
I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120
 WITH ASSEMBLY
 LOT CODE 5678
 ASSEMBLED ON WW19, 1999
 IN THE ASSEMBLY LINE "A"

Note: "P" in assembly line
 position indicates "Lead-Free"

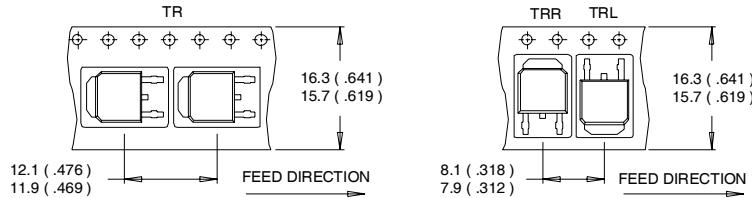


OR



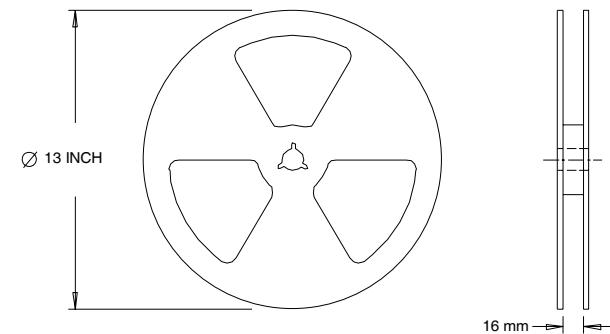
D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Data and specifications subject to change without notice.

International
IR Rectifier

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information.12/04

www.irf.com

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for infineon manufacturer:

Other Similar products are found below :

[TLE6209R](#) [EVALM113023645ATOBO1](#) [EVALM11302TOBO1](#) [FD1000R33HE3-K](#) [FD300R06KE3](#) [FF1200R17KE3_B2](#)
[FF300R06KE3HOSA1](#) [FF600R12ME4P](#) [FF600R17ME4_B11](#) [FP25R12KT4_B11](#) [FS600R07A2E3_B31](#) [FZ1600R17HP4_B2](#)
[FZ1800R17KF4](#) [FZ2400R17HE4_B9](#) [FZ600R65KE3](#) [DD261N22K](#) [DF1000R17IE4](#) [AUIRL1404ZS](#) [BAS 40-04 E6327](#)
[BAS4007WH6327XTSA1](#) [BAS 70-04 E6327](#) [BAS 70-06 E6327](#) [BAT15099E6327HTSA1](#) [BAT 165 E6327](#) [BAT 60A E6327](#) [BAT 60B E6327](#) [BC 817SU E6327](#) [BC 817U E6327](#) [BC 817UPN E6327](#) [BC 846PN H6327](#) [BC 846UPN E6327](#) [BC 847PN H6327](#) [BCM 856S H6327](#)
[BCP5416H6327XTSA1](#) [BCP55H6327XTSA1](#) [BCP5616H6327XTSA1](#) [BCR 108 E6327](#) [BCR 10PN H6327](#) [BCR 133W H6327](#) [BCR 141 E6327](#) [BCR 141S H6327](#) [BCR 141W H6327](#) [BCR 162 E6327](#) [BCR 183W H6327](#) [BCR 185S H6327](#) [BCR 192 E6327](#) [BCR 198 E6327](#) [BCR 35PN H6327](#) [BCR 523U E6327](#) [BCR 533 E6327](#)